IN THE UNITED STATES PATENT OFFICE

In re application of:

Yongjun J. Hu

Serial No.: Not Assigned

Filed: November 20, 2003 (Concurrently Herewith)

For: METHOD AND STRUCTURE FOR REDUCING RESISTANCE OF A SEMICONDUCTOR DEVICE

FEATURE

Group Art Unit: Not Assigned § §

Examiner: Not Assigned

Atty. Docket: 2003-0930.00/US

Paper No. *

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Mail Stop Patent Application Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

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"Express Mail" mail number: ET658403248US

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I hereby certify that this paper is being deposited with the United States Postal Service "Express Mail Post Office to Addressee" service under 37 CFR §1.10 on the date indicated above and is addressed to the Commissioner for Patents, PO Box 1450,

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INFORMATION DISCLOSURE STATEMENT

In compliance with the duty of disclosure under 37 CFR §1.56, Applicant respectfully requests entry of this Information Disclosure Statement, and that the references listed on the attached Form PTO-1449 be considered by the Examiner and made of record. A copy of any reference required for its consideration is enclosed.

In accordance with 37 CFR §1.97(b), this Information Disclosure Statement is not to be construed as a representation that a search has been made or that no other possible material information as defined in 37 CFR §1.56(a) exists.

Inventors: Yongjun J. Hu.

The following references are submitted for the Examiner's review:

U.S. Patent Documents

Document No.	Date	Inventor		
6,297,152	10/2001	Itoh et al.		
6,451,644	09/2002	Yu		
6,365,507	04/2002	Hu		
6,486,060	11/2002	Hermes et al.		

Other References:

Copending Application: "Conductive Transistor Structure for a Semiconductor Device and Method for Forming Same", Serial number 10/418,412, Docket Number 2002-1377.00, Filed April 16, 2003.

As this Information Disclosure Statement is being submitted before the mailing of a first Office Action on the merits, no fee is due. However, the Commissioner is authorized to charge any required fee to Micron Technology Inc. Deposit Account No.13-3092, Order No. 2003-0930.00/US.

If there are any matters which may be resolved or clarified through telephone interview, the Examiner is respectfully requested to contact Applicant's undersigned agent at the number indicated.

* * * *

A Form PTO-1449 is enclosed herewith.

Respectfully submitted,

Kevin D. Martin

Agent for Applicant

Registration No. 37,882

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e-mail: kmartin@micron.com

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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication with applicant.